Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/662,845	WANG ET AL.
	Examiner	Art Unit	
	Cuong Q. Nguyen	2811	

SEARCHED			
Class	Subclass	Date	Examiner
438	300-305 591-595	1-31-06 1(	ω 1/

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR

Su INTERFERENCE SEARCHED note

Class	Subclass	Date	Examiner

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Part of Paper No. 013106